

# FDP12N50 / FDPF12N50T N-Channel MOSFET 500V, 11.5A, 0.65Ω

# Features

- $R_{DS(on)} = 0.55\Omega (Typ.) \otimes V_{GS} = 10V, I_D = 6A$
- Low gate charge (Typ. 22nC)
- Low Crss ( Typ. 11pF)
- · Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- RoHS compliant

GDS

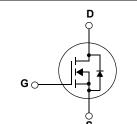


GDS

# Description

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficient switched mode power supplies and active power factor correction.



## MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted\*

**TO-220** 

**FDP Series** 

Symbol		Parameter		FDP12N50	FDPF12N50T	Units
V <sub>DSS</sub>	Drain to Source Voltage			500		V
V <sub>GSS</sub>	Gate to Source Voltage		ŧ	:30	V	
1	Droip Current	-Continuous (T <sub>C</sub> = 25 <sup>o</sup> C)		11.5	11.5 *	•
I <sub>D</sub>	DrainCurrent	-Continuous (T <sub>C</sub> = 100 <sup>o</sup> C)		6.9	6.9 *	A
I <sub>DM</sub>	Drain Current	- Pulsed	(Note 1)	46	46 *	А
E <sub>AS</sub>	Single Pulsed Avalanche Energ	(Note 2)	456		mJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	1	1.5	А	
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	1	16.7		
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5		V/ns	
D	Dower Dissinction	(T <sub>C</sub> = 25 <sup>o</sup> C)		165	42	W
P <sub>D</sub>	Power Dissipation	- Derate above 25°C		1.33	0.3	W/ºC
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range			-55 t	-55 to +150	
Τ <sub>L</sub>	Maximum Lead Temperature fo 1/8" from Case for 5 Seconds		300		°C	
	1/8" from Case for 5 Seconds imited by maximum junction temperature					

TO-220F

**FDPF Series** 

## Thermal Characteristics

Symbol	Parameter	FDP12N50	FDPF12N50T	Units
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	0.75	3.0	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.5	-	°C/W
$R_{ ext{ heta}JA}$	Thermal Resistance, Junction to Ambient	62.5	62.5	

May 2012

UniFET<sup>™</sup>

Device Marking		Device	Packa	ge	Reel Size	Tape Width			Quantity		
FDP12N50 FDP12N50		TO-22	20	-		-		50			
FDPF12N50T FDPF12N50T TO-22		0F	-		-		50				
Electrica	l Char	acteristics									
Symbol	Symbol Parameter			Test Conditions		Min.	Тур.	Max.	Units		
Off Charac	teristic	S									
3V <sub>DSS</sub>	Drain to	Drain to Source Breakdown Voltage			$I_D = 250 \mu A, V_{GS} = 0V, T_J = 25^{\circ}C$			-	-	V	
ΔTJ	Breakdown Voltage Temperature Coefficient			$I_D = 250 \mu A$ , Referenced to $25^{\circ}C$		-	0.5	-	V/ºC		
	Zere Cete Maltere Drein Current				V <sub>DS</sub> = 500V, V <sub>GS</sub> = 0V		-	-	1	۸	
I <sub>DSS</sub> Zero Gate Voltage Drain Current		ent	V <sub>DS</sub> =	400V, T <sub>C</sub> = 125 <sup>o</sup> C		-	-	10	μA		
GSS	Gate to Body Leakage Current			V <sub>GS</sub> =	$\pm 30$ V, V <sub>DS</sub> = 0V		-	-	±100	nA	
On Charac	teristic	S									
V <sub>GS(th)</sub>	Gate T	hreshold Voltage		V <sub>GS</sub> =	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 250μA			-	5.0	V	
R <sub>DS(on)</sub>	Static I	tatic Drain to Source On Resistance			$V_{GS} = 10V, I_D = 6A$			0.55	0.65	Ω	
9 <sub>FS</sub>	Forward Transconductance			V <sub>DS</sub> =	40V, I <sub>D</sub> = 6A	(Note 4)	-	11.5	-	S	
Dynamic C	haract	eristics									
C <sub>iss</sub>	Input C	apacitance			-	985	1315	pF			
Coss	Output	utput Capacitance		20	−V <sub>DS</sub> = 25V, V <sub>GS</sub> = 0V _ f = 1MHz		-	140	190	pF	
C <sub>rss</sub>	Revers	everse Transfer Capacitance		1 - 110	11 12		-	11	17	pF	
ე <sub>g</sub>	Total G	I Gate Charge at 10V				-	22	30	nC		
Q <sub>gs</sub>	Gate to	Gate to Source Gate Charge			$V_{DS} = 400V, I_{D} = 11.5A$		-	6	-	nC	
Q <sub>gd</sub>	Gate to	Gate to Drain "Miller" Charge		v <sub>GS</sub> =	V <sub>GS</sub> = 10V (Note 4, 5)		-	9	-	nC	
Switching	Charac	teristics									
d(on)	Turn-O	n Delay Time					-	24	60	ns	
r	Turn-O	n Rise Time		V <sub>DD</sub> =	V <sub>DD</sub> = 250V, I <sub>D</sub> = 11.5A		-	50	110	ns	
d(off)	Turn-O	Turn-Off Delay Time		R <sub>G</sub> = 2	$R_{G} = 25\Omega$		-	45	100	ns	
f	Turn-Off Fall Time					(Note 4, 5)	-	30	70	ns	
Drain-Sou	ce Dio	de Characteristic	S								
S	Maximu	m Continuous Drain to	Source Diod	de Forwa	ard Current		-	-	11.5	A	
SM	Maximum Pulsed Drain to Source Diode For			orward C	rward Current			-	46	Α	
/ <sub>SD</sub>	Drain to Source Diode Forward Voltage			V <sub>GS</sub> = 0V, I <sub>SD</sub> = 11.5A			-	-	1.4	V	
rr	Reverse	e Recovery Time	-		$V_{GS} = 0V, I_{SD} = 11.5A$ $dI_F/dt = 100A/\mu s$ (No		-	375	-	ns	
2 <sub>m</sub>		e Recovery Charge						3.5	1	μC	

1. Repetitive Rating: Pulse width limited by maximum junction temperatur

2. L = 6.9mH, I<sub>AS</sub> = 11.5A, V<sub>DD</sub> = 50V, R<sub>G</sub> = 25 $\Omega$ , Starting T<sub>J</sub> = 25°C

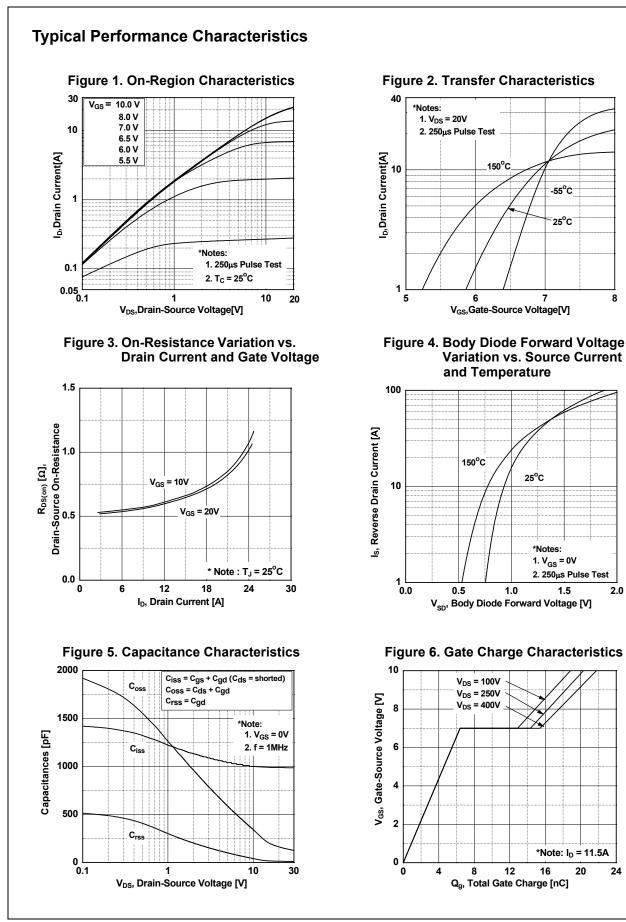
3.  $I_{SD} \le 11.5A$ , di/dt  $\le 200A/\mu$ s,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ 

4. Pulse Test: Pulse width  $\leq 300 \mu s,$  Duty Cycle  $\leq 2\%$ 

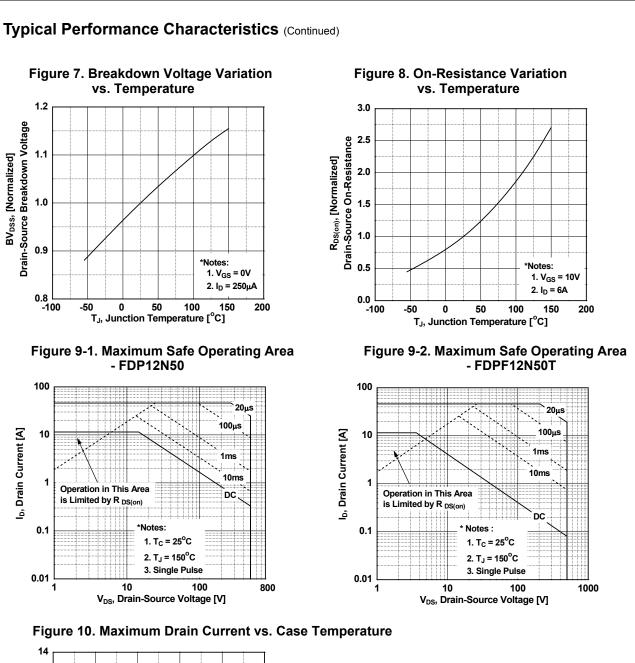
5. Essentially Independent of Operating Temperature Typical Characteristics

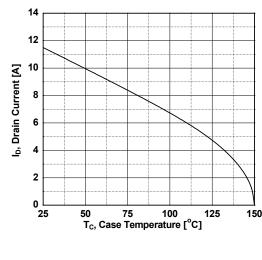
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2.0



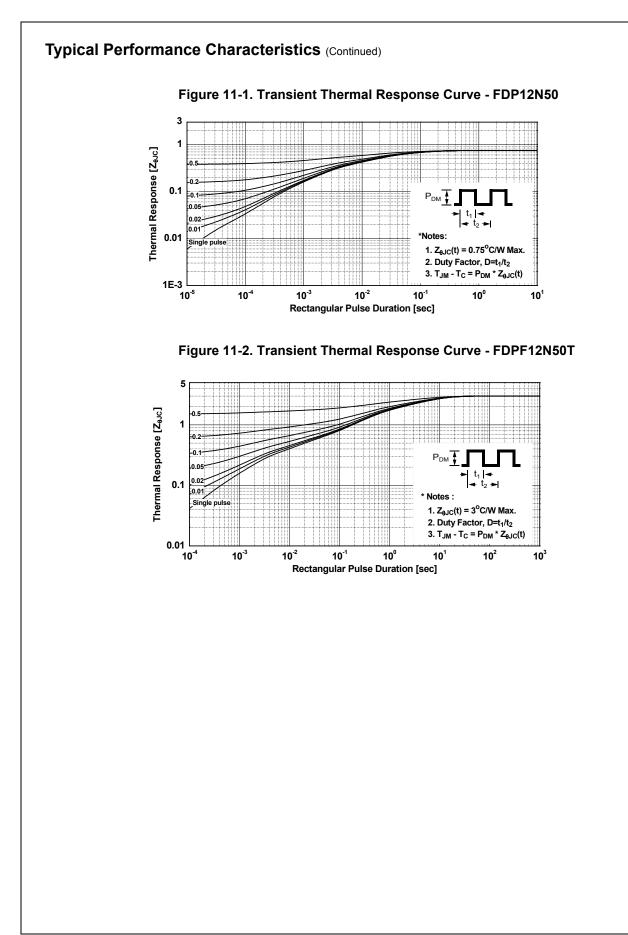
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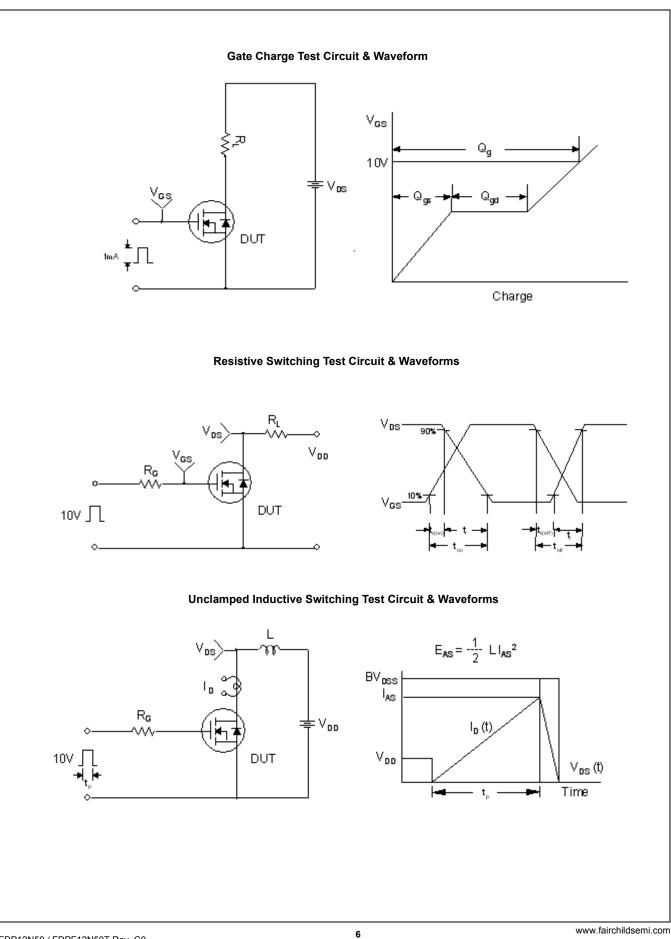


BV<sub>DSS</sub>, [Normalized]

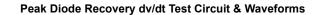
I<sub>D</sub>, Drain Current [A]

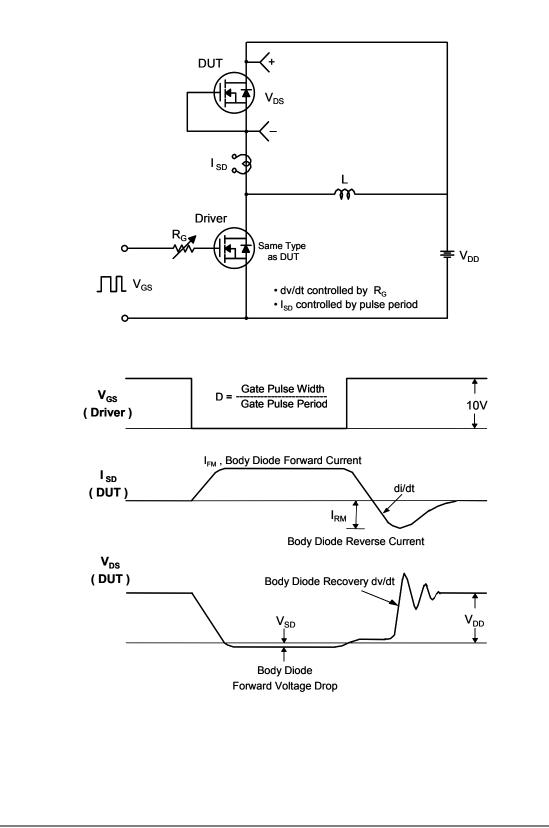


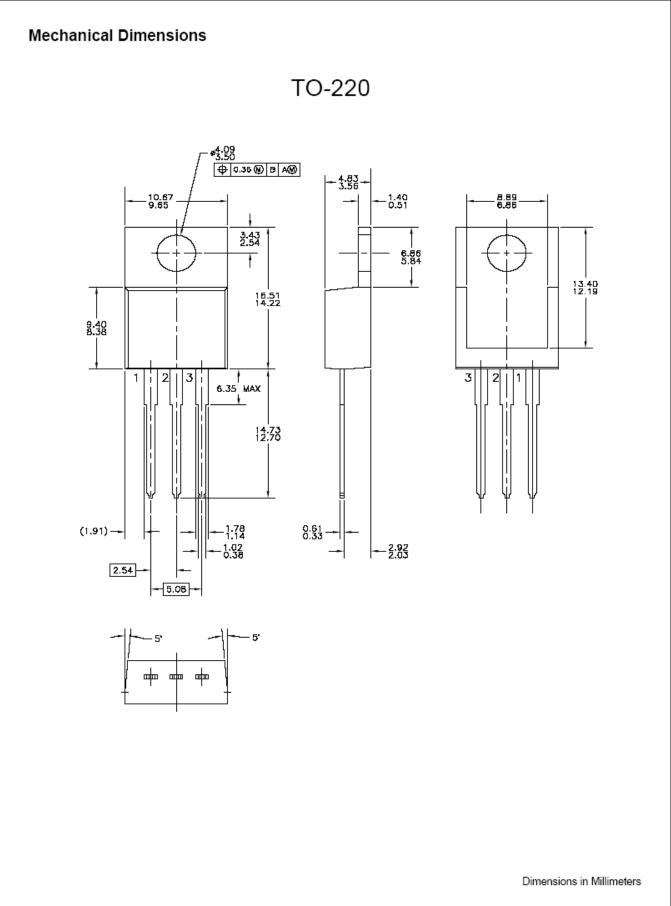




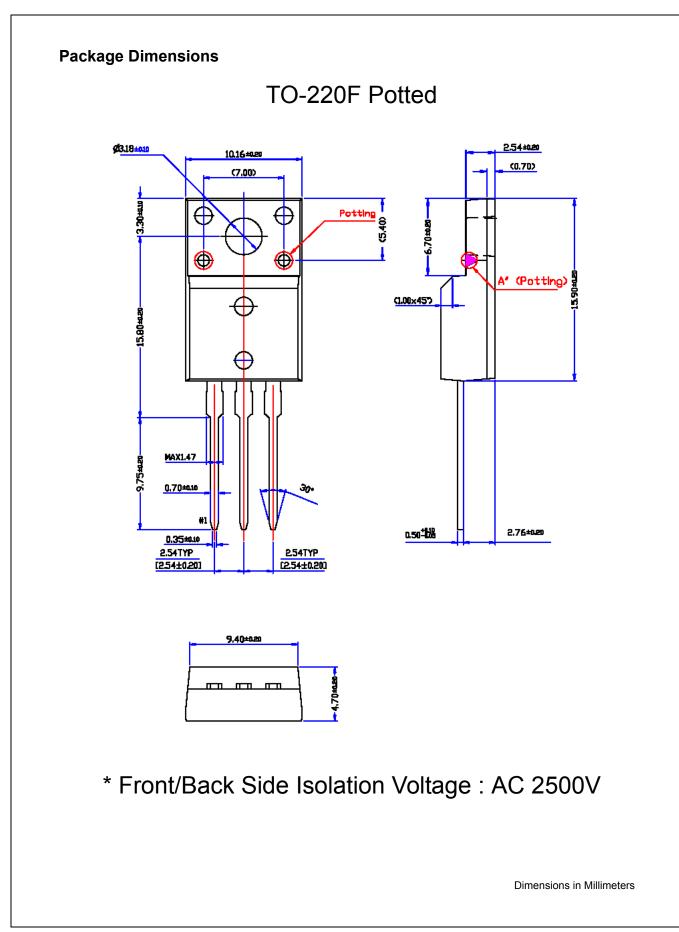
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